



## OCTAL POWER SOURCEING EQUIPMENT

### FEATURES

- Compliant to Power Over Ethernet IEEE 802.3af Standard
- Two-Point 25-k $\Omega$  Resistor Discovery
- Capacitive Detection for Non-Compliant Legacy Loads
- Power Classification
- Controlled di/dt Ramp Power-Up and Power-Down for EMI Reduction
- Current Management for Charging Powered Device Bulk Capacitance
- Electronic Circuit Breaker
- Fault detection
- Input Undervoltage Lockout (UVLO)
- Load Overcurrent and Undercurrent Detection
- 12-Bit Port Current and Voltage Acquisition
- Standard Slave I<sup>2</sup>C Serial Interface
- 5-Bit Serial Address Selectability
- Discovery and/or Classification Bypass

### Modes Selectable Via Register

- Opto-Coupler Compatible SDA and SCL Lines for System Ground Isolation
- Dual Color LED Driver for Port Status
- Hardware FAULT Interrupt

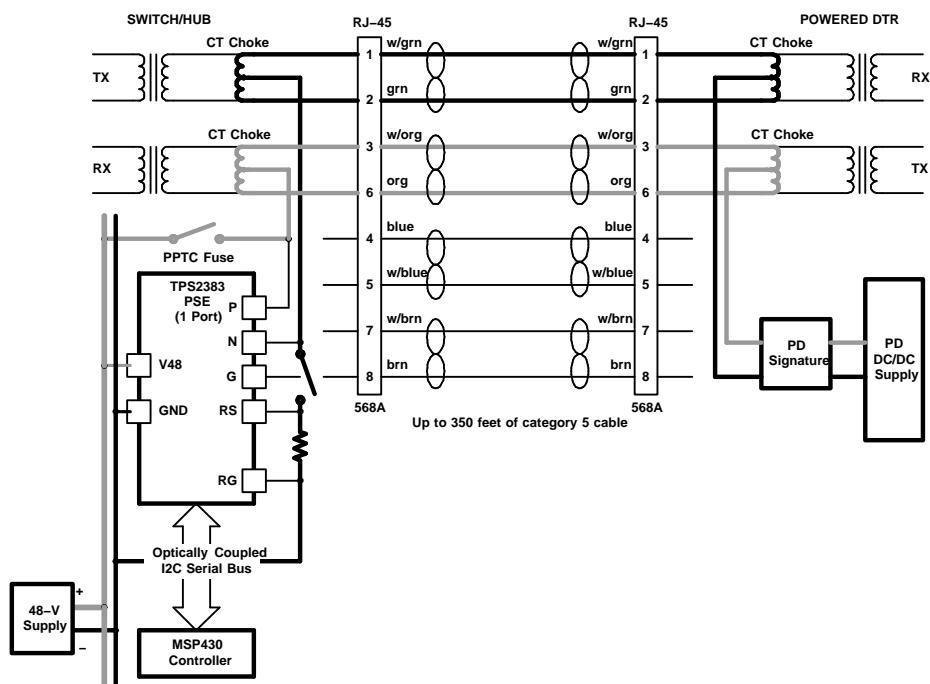
### APPLICATIONS

- PoE Switches
- Mid-Span Injectors

### DESCRIPTION

The TPS2383B is a power sourcing equipment power manager (PSEPM) that are compliant to the power-over-ethernet (PoE) IEEE 802.3af Standard. A PSEPM port can discover, classify and deliver power to a powered device (PD) capable of accepting PoE twisted pair cable. The TPS2383B is fully programmable by the user. This allows for the detection and powering of both fully compliant 802.3 devices as well as custom detection of legacy devices.

### APPLICATION DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## DESCRIPTION (CONTINUED)

The TPS2383B PSEPM can individually manage power for up to eight ethernet ports. All operations of the TPS2383B are controlled through register read and write operations over a standard (slave) I<sup>2</sup>C serial interface. The TPS2383B has dual SDA lines to allow easy application of opto-coupler circuitry to maintain ethernet port isolation when a ground based controller is used. Each TPS2383B has five selection pins making it possible to address up to 32 devices on the I<sup>2</sup>C bus and allows individual control and monitoring of up to 256 ethernet ports from a single master I<sup>2</sup>C controller. Per-port write registers initiate and manipulate the flow of the discovery, classification, and power-up states while the read registers contain status information of the enable process, faults, classification value, and real time port operating current and voltage. Per-port status LED drivers are provided which can be manually controlled through the serial I/O.

The TPS2383B is available in a full function 64-pin LQFP.

External N-channel MOSFETs switch port power. High-voltage (HV) gate drive ensures that these FETs are fully enhanced, resulting in lower power dissipation and enabling the use of lower costs FETs. The TPS2383B generates its HV gate supply from the 48-V port power, simplifying system power supply design. An external 3.3-V digital supply is also used. This supply can be active when 48-V power is not present which allows the user to access the part through the serial I/O in this case. A 5-V analog supply is used to power port LEDs and internal analog functions. Due to the very low quiescent current, both the 3.3-V and 5-V supply can be generated from the 48-V power bus with minimal external components. An internal power-on-reset (POR) circuit with an ORed external input pin resets all registers positions to a known safe state upon power up.

## ORDERING INFORMATION

T <sub>A</sub>	PACKAGE DEVICES <sup>(1)</sup>
	LQFP-64 (PM)
–40°C to 85°C	TPS2383BPM

(1) The PM package is available taped and reeled. Add R suffix to device type (e.g. TPS2383BPMR) to order quantities of 2,500 devices per reel.

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		TPS2383B
		UNITS
V <sub>CC</sub>	Input voltage range	V48, 1P, 2P, 3P, 4P, 5P, 6P, 7P, 8P, 1N, 2N, 3N, 4N, 5N, 6N, 7N, 8N
		1RS, 2RS, 3RS, 4RS, 5RS, 6RS, 7RS, 8RS, 1G, 2G, 3G, 4G, 5G, 6G, 7G, 8G, V10
		VL
		V5
		SCL_I, SDA_I, SDA_O, INTB, A1, A2, A3, A4, A5, EN, PORB
T <sub>stg</sub>	Storage temperature	–0.5 to 80 V
T <sub>J</sub>	Operating temperature	–0.5 to 12 V
T <sub>sol</sub>	Lead temperature	–0.5 to 3.9 V
		–0.5 to 6 V
		–0.5 to 6V
T <sub>stg</sub>		–55 to 150°C
T <sub>J</sub>		–40 to 125°C
T <sub>sol</sub>		260°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltages are with respect to GND. Currents are positive into and negative out of, the specified terminal.

## RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V <sub>V48</sub>	Input voltage	44	48	57	V
T <sub>a</sub>	Operating ambient temperature	-40		85	°C

## ELECTROSTATIC DISCHARGE (ESD) PROTECTION

	MAX	UNIT
Human body model	1.5	kV
CDM	1	
Machine model	0.2	

## OPERATING TEMPERATURE RANGE

PACKAGE	θ <sub>jc</sub>	θ <sub>ja</sub>	T <sub>A</sub> ≤ 25°C POWER RATING	DERATING FACTOR ABOVE TA = 25°C	T <sub>A</sub> = 85°C POWER RATING
LQFP-64	9°C/W	65°C/W	1.5 W	15.4 mW/°C	615 mW

## ELECTRICAL CHARACTERISTICS

V<sub>V48</sub> = 48 V, R<sub>T</sub> = 120 kΩ, -40°C to 85°C, and T<sub>A</sub> = T<sub>J</sub> (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>POWER SUPPLIES</b>						
V <sub>48</sub>	Quiescent current	Off mode (all ports)	3	5		mA
		Powered mode (all ports)	5	10		
V <sub>5</sub>	Quiescent current	Powered mode (all ports)	V <sub>V5</sub> = 5 V	3	15	
	Quiescent current	Powered mode (all ports)	V <sub>VL</sub> = 3.3 V	0.28	4	
V <sub>10</sub>	Internal analog supply		9.75	10.50	11.50	V
	Internal reference <sup>(1)</sup>		2.475	2.500	2.525	
	Input UVLO		30	38		
	Internal POR timeout (I <sup>2</sup> C)	After all supplies are good (8 CLK periods)	8			
	Internal POR timeout (state machine)	After all supplies are good (65536 CLK periods)	65536			CLKs
<b>LED OUTPUTS</b>						
	High-level output voltage, L <sub>1</sub> through L <sub>8</sub>	I <sub>SRC</sub> = 5 mA	4			V
	Low-level output voltage, L <sub>1</sub> through L <sub>8</sub>	I <sub>SRC</sub> = 5 mA		0.75		
	Tri-state leakage <sup>(1)</sup>		0.1			µA
<b>ANALOG CIRCUITS – PORT VOLTAGE CONTROL LOOP</b>						
nP to nN	Input resistance		480	800	1280	kΩ
	Classification voltage	A/B select = B	15.5	17.5	20.5	V
	Discovery voltage, high		7.5	8.8	9.5	
	Discovery voltage, low		3.5	4.4	5.5	
	Loop power supply feedthru loop control range C <sup>(1)</sup>		1.5			mV
	Discovery short-circuit current			3		mA
	Port output, undervoltage		40	42	44	V
	Port output, overvoltage		56.0	59.5	63.0	

(1) Ensured by design. Not production tested.

**ELECTRICAL CHARACTERISTICS (continued)**

$V_{V48} = 48$  V,  $R_T = 120$  k $\Omega$ ,  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ , and  $T_A = T_J$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Classification current limit	ClassLimit1 = 0, ClassLimit2 = 0	160			mA
	ClassLimit1 = 1, ClassLimit2 = 0	80			
	ClassLimit1 = 0, ClassLimit2 = 1	40			
	ClassLimit1 = 1, ClassLimit2 = 1	20			
<b>N-CHANNEL MOSFET GATE CONTROL</b>					
	Gate turn-off MOSFET $R_{DS(on)}$	200			$\Omega$
	Maximum gate voltage	8	10	12	V
	Gate turn-off timer from UV/OV fault	After port enabled and ramped up, (1024 CLK periods)	1024		CLKs
	UV/OV spike timer, power quality warning <sup>(1)</sup>	(256 CLK periods)	256		
	Gate turn-off timer from overload fault	(32768 CLK periods)	32768		
<b>LOW-SIDE CURRENT-SENSE</b>					
	Overload threshold voltage	175	187	200	mV
	Current limit threshold voltage	200	213	225	
CINT	Maximum swing	9	11		V
CINT	Reset voltage	10	100		mV
CINT	Internal pull-up current $V_{CINT} < 1.25$ V, A/D inputs = $-100$ mV	850			nA
CR	Maximum swing	4.5	6.0		V
$nRS$	Input leakage	10			$\mu\text{A}$
<b>ANALOG-TO-DIGITAL CONVERTER</b>					
	A/D resistive scaling $R_{RD} = 1$ k $\Omega$	72			count/k $\Omega$
	Port-to-port resistance variation	Referenced to port #1	-5%	0%	5%
	A/D classificatin scaling <sup>(2)</sup> $R_{RS} = 0.5$ $\Omega$	35			counta/mA
	A/D load current scaling <sup>(2)</sup> $R_{RS} = 0.5$ $\Omega$	4.72			
	A/D load voltage scaling <sup>(2)</sup>	33.6			count/V
	A/D load current conversion $I_{LOAD} = 50$ mA, $R_{RS} = 0.5$ $\Omega$	236			count
	$I_{LOAD} = 300$ mA, $R_{RS} = 0.5$ $\Omega$	1416			
	A/D port voltage conversion $V_{PORT} = 5$ V	168			
	$V_{PORT} = 45$ V	1512			
<b>DIGITAL I/O</b>					
SCL, SDA_I, A1 through A5, EN, PORB	Logic input threshold voltage	1.5			V
SCL, SDA_I	Input hysteresis	250			mV
EN, PORB	Input hysteresis	150			
EN, PORB	Input pull-down resistance	50			k $\Omega$
A0, A1, A2, A3, A4, A5	Pull-up current	10	25		$\mu\text{A}$
SDA_O	Logic high leakage Drain = 6 V	10			
SDA_O	Logic low output voltage $I_{SINK} = 3$ mA	200			
INTB	Logic high leakage Drain = 6 V	10			$\mu\text{A}$

(2) Ensured by design. Not production tested.

**ELECTRICAL CHARACTERISTICS (continued)**

$V_{V48} = 48$  V,  $R_T = 120$  k $\Omega$ ,  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ , and  $T_A = T_J$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
INTB		$I_{SINK} = 3$ mA			200	mV	
<b>DIGITAL I/O TIMING I<sup>2</sup>C CHARACTERISTICS</b>							
SCL	Clock frequency		0	400	kHz		
Pulse duration	SCL high		1.3	ns	0.6	$\mu\text{s}$	
	SCL low						
SCL, SDA <sup>(2)</sup>	Rise time				300	ns	
SCL, SDA <sup>(2)</sup>	Fall time				300		
	Setup time SDA to SCL				250	$\mu\text{s}$	
	Hold time SCL to SDA				0		
	Bus free time between startup and stop				1.3		
	Setup time SCL to start condition				0.6		
	Hold time start condition to SCL				0.6		
	Setup time, SCL to stop condition				0.6		

**DEVICE INFORMATION**
**TERMINAL FUNCTIONS**

TERMINAL	I/O	DESCRIPTION
NAME	NO.	
<b>POWER AND GROUND</b>		
AG1	26	I
AG2	51	I
DG	56	I
RG	29	I
V10	28	O
V48	27	I
V5	25	I
VL	54	I

AG1: Analog ground 1. Analog ground of the V5, V10 and V48 power systems. It should be externally tied to the common copper 48-V return plane. This pin should carry the low side of two de-coupling capacitors tied to V48 and V10.

AG2: Analog ground 2. Analog ground, which ties to the substrate and ESD of the device. It should be externally tied to the common copper 48-V return plane. AG1 and AG2 must be tied together directly for lowest noise operation.

DG: Digital ground. It connects to the internal logic ground bus. It should be externally tied to the common copper 48V return plane. In addition a 0.1 $\mu\text{F}$  de-coupling capacitor should terminate as close to this node and the VL pin as possible.

RG: Reference ground. A precision sense of the external ground plane. It should also be used as the ground guard ring for the integration capacitor (CINT). It should be the closest ground to the low side of the 0.5- $\Omega$  current sense resistors, as well as RD, CINT, and RT. It should tie to common copper 48-V return plane.

V10: +10V analog supply. Connects to the internal analog power bus. This voltage is generated internally. This pin should not be tied to any external supplies. A 0.1- $\mu\text{F}$  de-coupling capacitor should terminate as close to this node and the AG2 pin as possible. This pin can be used for external generation of V5.

V48: +48V input to the device. This supply can have a range of 44 V to 57 V. This pin should be de-coupled with a 0.1- $\mu\text{F}$  capacitor from V48 to AG2 placed as close to the device as possible.

V5: External +5V analog supply. Connects to the internal analog power bus. This supplies the LED output drivers and internal analog circuits. A 0.1- $\mu\text{F}$  de-coupling capacitor should terminate as close to this node and the AG1 pin as possible.

VL: External +3.3V logic supply. This pin connects to the internal logic power bus. This is the supply voltage for the internal device logic. A 0.1- $\mu\text{F}$  de-coupling capacitor should terminate as close to this node and the DG pin as possible. This pin can be powered from V5 by using a 4.22-k $\Omega$  resistor from V5 to VL..

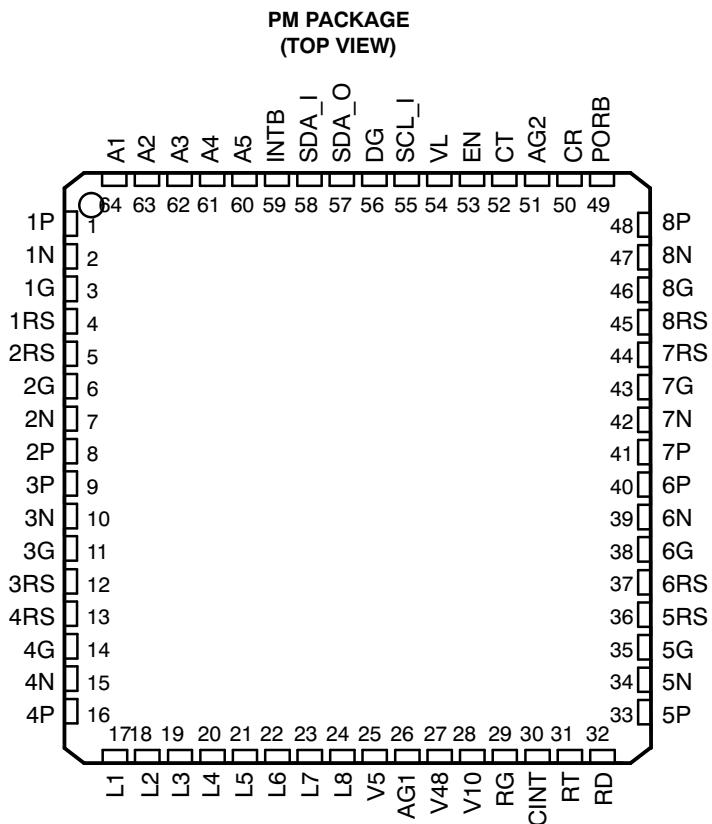
**DEVICE INFORMATION (continued)****TERMINAL FUNCTIONS (continued)**

TERMINAL	I/O	DESCRIPTION
NAME	NO.	
<b>PORT ANALOG SIGNALS</b>		
1P	1	I
2P	8	I
3P	9	I
4P	16	I
5P	33	I
6P	40	I
7P	41	I
8P	48	I
1N	2	I
2N	7	I
3N	10	I
4N	15	I
5N	34	I
6N	39	I
7N	42	I
8N	47	I
1G	3	O
2G	6	O
3G	11	O
4G	14	O
5G	35	O
6G	38	O
7G	43	O
8G	46	O
1RS	4	I
2RS	5	I
3RS	12	I
4RS	13	I
5RS	36	I
6RS	37	I
7RS	44	I
8RS	45	I
<b>ANALOG SIGNALS</b>		
CR	50	I
CT	52	I
CINT	30	I

**DEVICE INFORMATION (continued)**
**TERMINAL FUNCTIONS (continued)**

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
L1	17	O	LED lamp drivers. Dual or single color LEDs can be connected to each of these pins. Each pin indicates the state of the corresponding port. This is a tri-state port that is under full control of the host micro-controller. As such it can also be used as a data port, or general-purpose output driver.
L2	18	O	
L3	19	O	
L4	20	O	
L5	21	O	
L6	22	O	
L7	23	O	
L8	24	O	
RD	32	I	The discovery current-sense resistor is connected in the path from the RD pin to RG ground. The discovery current-sense resistor sets the discovery value to 25-k $\Omega$ (nominal) when a 665- $\Omega$ value is used. For best noise performance, de-couple this pin with a 0.68- $\mu$ F, ceramic capacitor to RG ground.
RT	31	I	Bias set resistor. This resistor sets all precision bias currents within the device. This pin is forced to an internal 1.25-V reference voltage level. The current that flows into this resistor due to the applied 1.25-V bias is replicated and used throughout the device. This resistor also works in conjunction with the capacitors on CR, CT and CINT to set internal timing values. Use a 120-k $\Omega$ resistor to be compliant to the requirements of 802.3af.
<b>DIGITAL SIGNALS</b>			
A1	64	I	Addresses 1 through 5. This is the I <sup>2</sup> C address select input. Select the appropriate binary address on these pins by connecting this pin to device ground for a logic low and tying this pin to the VL pin for a logic high.
A2	63	I	
A3	62	I	
A4	61	I	
A5	60	I	
EN	53	I	This pin is normally to be held low. It has been reserved for future expansion of the TPS238x device family
INTB	59	O	This is an open drain output that goes low if a fault condition is produced on any of the eight ports.
PORB	49	I	This pin can be used to override the internal POR. When held low, the I <sup>2</sup> C interface, all the state machines, and registers are held in reset. When all internal and external supplies are within specification, and this pin is set to a logic high level, the POR delay begins. The I <sup>2</sup> C interface and registers becomes active within eight CLK periods of this event and communications to read or preset registers can begin. The reset delay for the remainder of the device then extinguishes within 65536 CLK periods.
SCL_I	55	I	Serial clock input pin for the I <sup>2</sup> C interface.
SDA_I	58	I	Serial data input pin for the I <sup>2</sup> C interface. When jumpered with the SDA_O pin, this connection becomes the standard bi-directional serial data line (SDA).
SDA_O	57	O	Serial data open drain output for the I <sup>2</sup> C interface. When jumpered with the SDA_I pin, this connection becomes the standard bi-directional serial data line (SDA). This is a high-voltage open drain output that can drive opto-coupler LEDs directly from the +48-V bus with an external, series current limiting resistor.

## PACKAGE DESCRIPTION



## APPLICATION INFORMATION

The TPS2383B architecture has been designed to work efficiently with simple low-cost controllers such as those in the MSP430 family of devices. Reference design and code examples for complete PSE management are available from TI for the TPS2383B/MSP430 chipset solution.

The PSEPM discovery method, as defined in the IEEE 802.3af Standard, uniquely identifies a powered device 25-kΩ – resistor. Use of low-level probe signals during discovery prevents damage to non-802.3 devices. The use of a point-to-point slope detection method for the PD 25-kΩ resistor measurement allows accurate detection, even if series steering diodes are present at the PD. For legacy loads, capacitive detection can be enabled. In this mode the TPS2383B A/D is used to measure the loads capacitive value.

After a successful discovery of the PD, the TPS2383B has a classification feature to identify the expected PD power level based on a current signature from the PD. The classification current level is measured at a reduced terminal voltage of 17.5 V and classified with 12 bits of resolution. The controller can then use this information to classify per the levels of the IEEE 802.3af standard or use levels custom to the application. Knowledge of the expected load power allows the power sourcing equipment to be built with a smaller and less expensive system power supply. For installations where classification is not needed, and reduced power-up time is desired, classification can be bypassed by setting the appropriate bits in the per-port write register.

In classification and powered modes, the PSEPM drives an external low side N-channel MOSFET for control of the 48-V return line. The use of an external N-channel MOSFET enables selection of very low RDS(on) devices to minimize board power dissipation in enclosures that may be controlling 100's of ports. Current sensing performed with a low value resistor, again minimizing board power dissipation. In discovery mode, due to the very low current used, an internal N-channel MOSFET is utilized in conjunction with an external, high value, current sense resistor.

## APPLICATION INFORMATION (continued)

The TPS2383B identifies all fault conditions defined in the PoE IEEE 802.3af Standard. The monitored conditions include input undervoltage lockout (UVLO), output undervoltage (UV) and overvoltage (OV), average and peak overcurrent detection, average undercurrent detection, and run current. If a fault condition is detected during power ramp or at any other time, the PSEPM circuit breaks by disconnecting the 48-V return line and then updates the fault status of the corresponding port register. When the TPS2383B is disabled the PSEPM ramps the current down at a controlled rate and the PSEPM changes states to a lower power sleep mode.

To maintain full compliance to Underwriters Laboratory (UL), IEC950 SELV and NEMKO safety standards an optional, low cost self-resetting PTC fuse can be added to the unswitched +48-V line to protect the system supply and wiring infrastructure from secondary building wiring faults.

When the PSEPM is enabled and a PD is discovered and optionally classified, power is ramped to the PD at a controlled current ramp rate to reduce EMI. Upon completion of the current ramp up, the port current remains limited at less than 400 mA. Upon startup the port can remain in current limit for a timed value of 50 ms which allows the bulk filter capacitance of the PD to charge. Once a PD is successfully powered and the external N-channel MOSFET is fully on, the average and peak current to the PD is continuously monitored. A disconnected load is detected if the average current falls below 10 mA. An overcurrent is detected if the average current exceeds 375 mA. If any of these conditions exist, status bits are set in the per-port read register set and the power is removed from the load.

For maximum rejection of external wiring and power supply noise sources during the measurement of line current, voltage, resistance or capacitance in discovery, classification and powered modes, a proprietary low noise A/D converter is used. Converted measurements are processed and compared with digital set-points for limit compliance. The 12-bit conversion of this data-acquisition system is available through the read register enabling measurement of the discovery resistance, classification current and powered mode port running current and voltage. This is a valuable feature in ethernet switch management as it allows monitoring of real-time parameters across the system network.

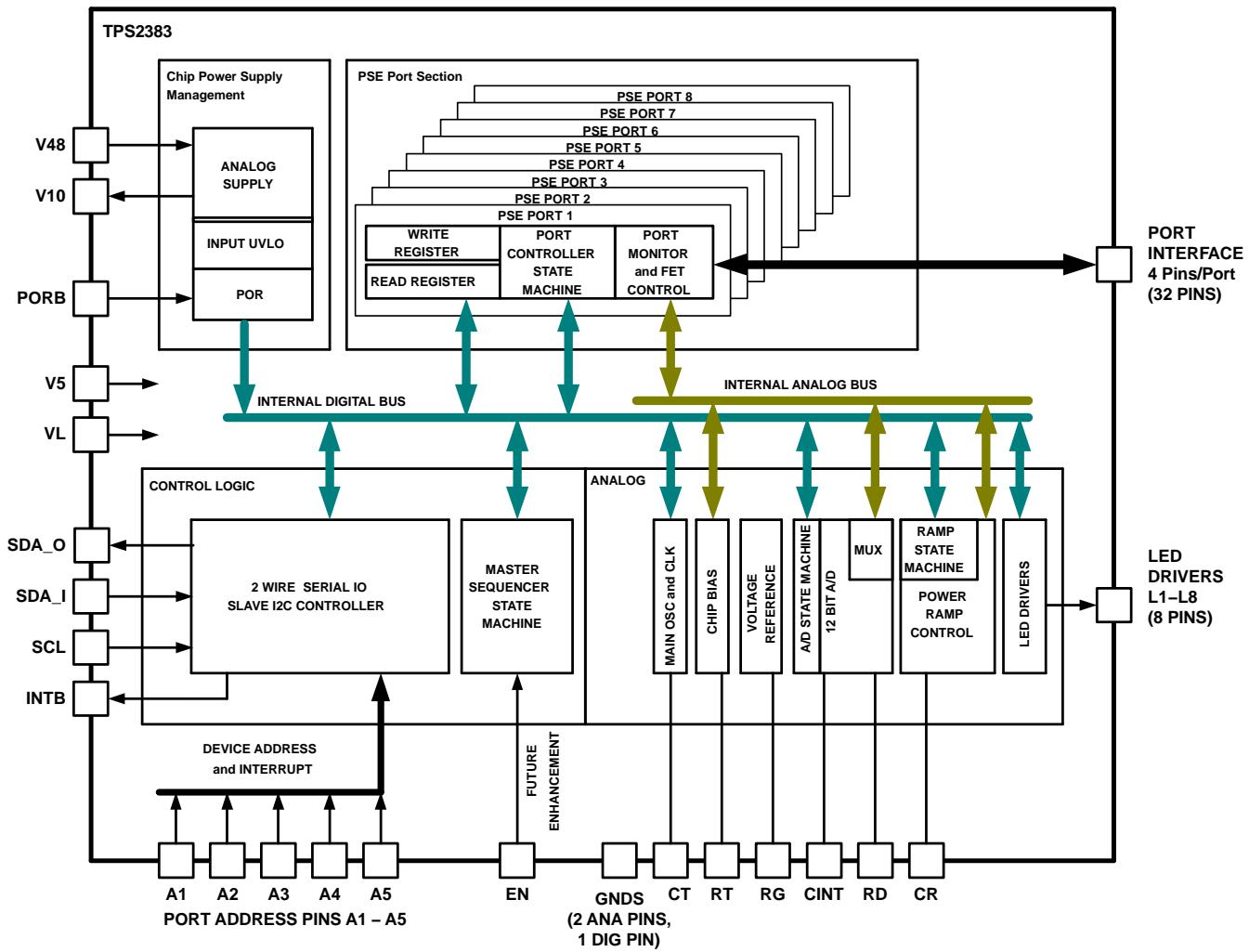
The TPS2383B is available in a full function 64 pin LQFP package.

## TPS2383B EVALUATION BOARD

The full performance features of the TPS2383B/MSP430 chipset can be demonstrated with the PMP395 evaluation board. The PMP395 board is a scaleable system that can be expanded to support 48 ports using a single microcontroller. This evaluation design can be used as a hardware/firmware template for modification to specific customer requirements. Please contact Texas Instruments or refer to the PMP395 User's Guide (SLUU177) for complete information.

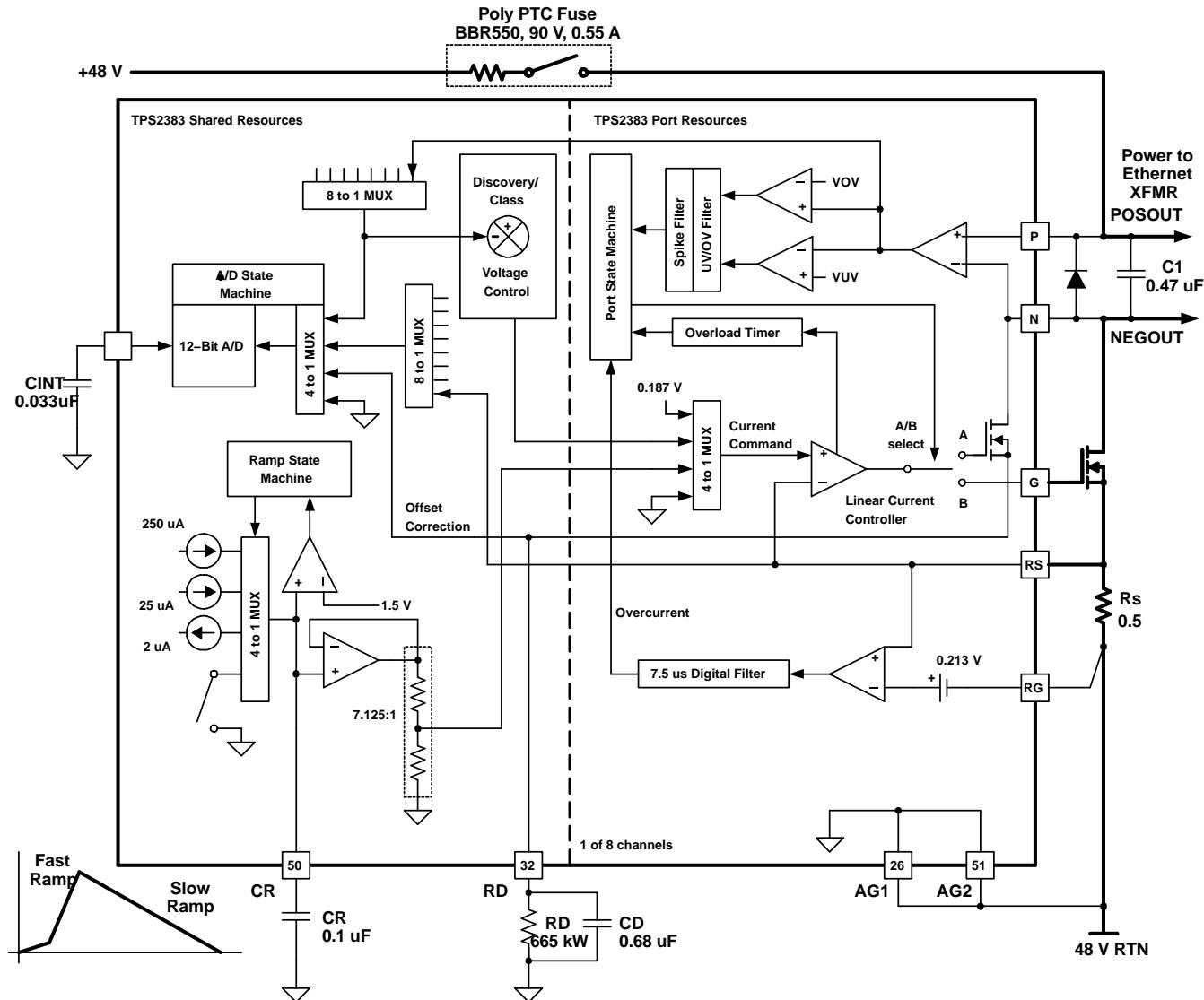
## APPLICATION INFORMATION (continued)

## FUNCTIONAL BLOCK DIAGRAM



## APPLICATION INFORMATION (continued)

### TPS2383B BLOCK DIAGRAM – SHARED PORT ANALOG RESOURCES



### SEPM STATE MACHINES

The TPS2383B has circuit resources that are common to each port and circuit resources that are shared by all ports. Five independent state machines are used to control the common and shared PSEPM resources. Port control, UV/OV/OC and overload protection are all features that are common to each port. Data acquisition and power ramping are shared functions for all the ports.

The master sequencer state machine is used to index the port presently being serviced and to distribute the shared resources to the currently selected port. The single master sequencer is responsible for incrementally accessing ports 1 through 8 and allowing those ports to process register data when they are accessed. Ports 1 through 8 each have a port sequencer, which controls all the power enabling and fault protection functions of the port per the register commands. The A/D has an A/D Sequencer that triggers, cycles and signals the port and master sequencer upon completion. The ramp sequencer controls the power ramping resource and is triggered by the port and master sequencer and provides a completion signal when power ramping is over.

## APPLICATION INFORMATION (continued)

Upon power-up the master sequencer is enabled and running after a POR delay and begins acting on register commands. A shorter POR delay releases the reset on the I<sup>2</sup>C function and registers before the port reset removed. This arrangement allows for register setup and polling over the I<sup>2</sup>C bus quickly upon power up but ensures that power cannot be applied until the power supply is fully energized and stable. The default power-up state for all command registers is a null condition. The state sequence order of the TPS2383B is discovery, classification and power delivery if a POE compliant device is detected on the other end of the data cable.

The master sequencer powers-up in a default free-running mode. The TPS2383B also has a JOG mode. By setting the JOG\_MODE register bit high, the master sequencer then no longer runs freely, but increments to the next sequential port each time the JOG register bit is set to a logic 1. The JOG bit is self-cleared once the port increments to the next position.

Sequencing starts with port 1 and ends with port 8 and then repeats. The port sequencer signals status information to the master sequencer and skips over disabled ports. When the master sequencer detects an enabled port, it pauses at that port until discovery, classification and power-up is complete before proceeding to the next. When the master sequencer reaches a powered port, it pauses and take a reading of the ports run-time current and/or voltage before proceeding to the next port. When a powered PD load is disconnected, the disconnect event can be detected the next time that port is selected by the master sequencer. When the disable bit of a powered port is set in the corresponding register, that operation is completed the next time the master sequencer selects that port. An overcurrent fault event shuts down the offending port independent of any sequencer state.

## DUAL COLOR LED DRIVERS

The LED driver pins (L1 through L8) can be used to drive single or dual, color LEDs. These LEDs are intended to provide installation or service personnel with the necessary information to install and troubleshoot the system infrastructure. The L<sub>n</sub> pins have internal tri-state drivers. These LEDs can be controlled directly from the I<sup>2</sup>C registers. The reset state of all the LEDs is tri-state. Cross-conduction logic disables both internal high- and low-side MOSFETS if an attempt is made to enable both transistors on a given port. These are high current (10-mA) drivers that can be used for other applications such as the drive of optocouplers or electromechanical devices, or can just be used as an 8-bit data port.

## APPLICATION INFORMATION (continued)

### I<sup>2</sup>C INTERFACE

The serial interface used in the TPS2383B is a standard two-wire I<sup>2</sup>C slave architecture core. The standard bi-directional SDA lines of the I<sup>2</sup>C architecture are broken out into an independent input and output path. This feature simplifies, earth grounded, controller applications that require opto-isolators to keep the 48-V return of the ethernet power system floating. For applications where opto-isolation is not required, the bi-directional property of the SDA line can be restored by connecting SDA\_I to SDA\_O. The SCL line is a unidirectional input only line as the TPS2383B is always accessed as a slave device and it never controls the bus.

Data transfers that require a data-flow reversal on the SDA line are four-byte operations. This occurs during a TPS2383B port read access cycle where a slave address byte is sent, followed by a port/register address byte write. A second slave address byte is sent followed by the data byte read using the port/register setup from the second byte in the sequence.

Data write transfers to the TPS2383B do not require a data-flow reversal and as such only a three-byte operation is required. The sequence in this case is to send a slave address byte, followed by a write of the port/register address followed by a write of the data byte for the addressed port.

The I<sup>2</sup>C access cycle consists of the following steps 1 through 7 and is also shown in Figure 4.

1. Start sequence (S)
2. Slave address field
3. Read/write
4. Acknowledge
5. Port/register address or data field
6. Acknowledge/not acknowledge
7. Stop sequence (P)

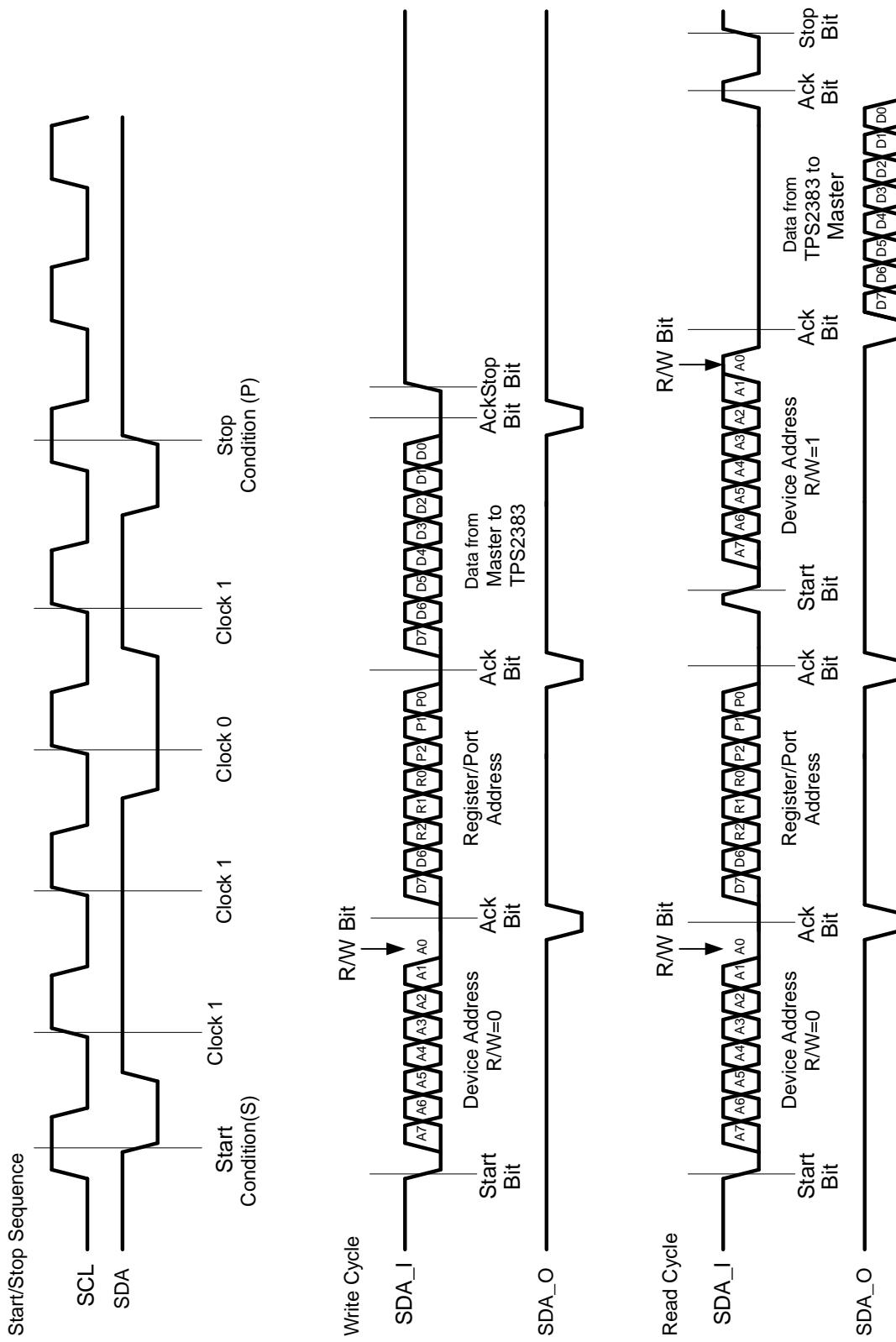
The I<sup>2</sup>C interface and the port read write registers are held in active reset until input voltage is within specification and the internal POR timer has timed out.

### START/STOP

The high-to-low transition of SDA while SCL is high defines the start condition. The low-to-high transition of SDA while SCL is high defines the stop condition. The master device initiates all start and stop conditions.

A first serial packet enclosed within start and stop bits, consists of a seven-bit address field, read/write bit, and the acknowledge bit. The acknowledge bit is always generated by the device receiving the address or data field. Five of the seven address bits are used by the TPS2383B. The sixth and seventh bit is a placeholder for future expansion. During a write operation to the TPS2383B from the master device, the data field is eight bits. During a read operation where the TPS2383B is writing to the master device, the data field is also eight bits.

## APPLICATION INFORMATION (continued)

Figure 1. I<sup>2</sup>C Read/Write Cycles

## APPLICATION INFORMATION (continued)

### CHIP ADDRESS

The address field of the TPS2383B is eight bits and contains five bits of device address select, a read/write bit, and two reserved bits per Table 1. The leading two bits are reserved for future port expansion, and must be set to 0 for address acknowledge. The five device address select bits follow this. These bits are compared against the hard-wired state of the corresponding, device address select pins (A1 through A5). When the field contents are equivalent to the pin logic states, the device is addressed. These bits are followed by a least significant bit (LSB), which is used to set the read or write condition (1 for read and 0 for write). Following a start condition and an address field, the TPS2383B responds with an acknowledgement by pulling the SDA line low during the ninth clock cycle if the address field is equivalent to the value programmed by the pins. The SDA line remains a stable low while the ninth clock pulse is high.

**Table 1. Address Selection Field**

BIT	FUNCTION
A7	Future expansion set to 0
A8	Future expansion set to 0
A5	Device address. Compared with A5
A4	Device address. Compared with A4
A3	Device address. Compared with A3
A2	Device address. Compared with A2
A1	Device address. Compared with A1
A0	Read/write

### PORTREGISTER CYCLE

After the chip address cycle, the TPS2383B accepts eight bits of port/register select data as defined in Table 2. The SCL line high-to-low transition after the eighth data bit then latches the selection of the appropriate internal register for the follow on data read or write operation. After latching the eight-bit data field, the TPS2383B pulls the SDA line low for one clock cycle.

### DATA WRITE CYCLE

For a data write sequence, after the Port/Register address cycle, the TPS2383B accepts the eight bits of data. The data is latched into the previously selected Write Register, and the TPS2383B generates a data acknowledge pulse by pulling the SDA line low for one clock cycle. To reset the interface, the host or master subsequently generates a Stop bit by releasing the SDA line during the clock-high portion of an SCL pulse.

## DATA READ CYCLE

For a data read sequence, after the register acknowledge bit, the master device generates a Stop condition. This is followed by a second Start condition, and retransmitting the device address as described in Chip Address above. For this cycle, however, the R/W bit is set to a 1 to signal the read operation. The TPS2383B again responds with an acknowledge pulse. The address acknowledge is then followed by sequentially presenting each of the eight data bits on the SDA line (MSB first), to be read by the host device on the rising edges of SCL. After eight bits are transmitted, the host acknowledges by pulling the SDA line high for one clock pulse. The completed data transfer is terminated with the host generating a Stop condition.

**Table 2. Register/Port Addressing**

BIT	FUNCTION	STATE
D7	Future expansion	
D6	Future expansion	
D5	R2, register select MSB	000 = Control (common Write register)
		001 = Port Status (per port Read register)
D4	R1, register select	010 = Port Control (per port Write register)
		011 = A2D Register low byte (common read register)
D3	R0, register select LSB	100 = A2D Register high byte (common read register)
		101 = Chip identification/revision (common read register)
D2	P2, port address MSB	000 = Port 1
		001 = Port 2
		010 = Port 3
D1	P1, port address	011 = Port 4
		100 = Port 5
		101 = Port 6
		110 = Port 7
D0	P0, port address LSB	111 = Port 8

**Table 3. Common Control**  
**Write Register, Register Address = 000 (Common Register)**

BIT	FUNCTION	STATE	PRESET STATE
D7	Jog-mode	0 = Normal mode 1 = Jog mode	0
D6	Jog	0 = Don't jog 1 = Jog. This bit is self-clearing. It does not need to be reset to a 0 for each new jog.	0
D5	Bypass ramp	0 = Normal mode 1 = Bypass power-up ramp and powered mode for all ports	0
D4	Disconnect disable	0 = Normal mode 1 = Disable the effect of the logic signal from the Disconnect detection circuits. This is an expansion function for future parts. This bit should be set to a logic 1	0
D3	Bypass discovery	0 = Normal mode 1 = Bypass discovery mode.	0
D2	Bypass sample	0 = Normal mode 1 = Bypass current sample of all powered ports.	0
D1	Bypass classification	0 = Normal mode 1 = Bypass classification of all ports.	0
D0	Discovery fault disable	0 = Normal mode 1 = Disable the effect of the logic signal from the Discovery circuits. This is an expansion function for future parts. This bit should be set to a logic 1.	0

## PORT STATUS REGISTERS

The Port Status registers (address 001) contain port specific information regarding the operational or faulted state of each of the eight Ethernet ports, as shown in Tables 4 and 5. In addition, the Port 1 Status register (Register/Port address xx00/1000) bits D6:D3 contain the current usage information of some of the common hardware resources, as they are accessed in the servicing of the port presently selected by the master sequencer.

**Table 4. Port Status**  
**Port 1 Read Register, Register Address = 001, Port Address = 000**

BIT	FUNCTION	STATE	PRESET STATE
D7	Port service	0 = Port not selected 1 = Port selected and being serviced	0
D6	Down	0 = Selected port is being ramped up 1 = Selected port is not being ramped up	1
D5	Ramp ServiceB	0 = Selected port is using the RAMP module 1 = Selected port is not using the RAMP module	1
D4	CurrentSampleB	0 = Selected port current is being acquired 1 = Selected port current is not being acquired	1
D3	A to D ServiceB	0 = Discovery/classification data acquisition in process 1 = A/D not performing a discovery/classification	1
D2	Fault status (MSB)	000 = Reset state 001 = UV/OV fault/spike 010 = UV/OV spike	000
D1	Fault status	100 = Overload fault 101 = Discovery Fail 110 = Load disconnect 111 = Reserved for future	
D0	Fault status (LSB)		

**Table 5. Port Status**  
**Read Register, Register Address = 001, Port Address = 001–111 (Port 2 through Port 8)**

BIT	FUNCTION	STATE	PRESET STATE
D7	Port service	0 = Port not selected 1 = Port selected and being serviced	0
D6	Spare		0
D5	Spare		1
D4	Spare		1
D3	Spare		1
D2	Fault status (MSB)	000 = Reset state 001 = UV/OV fault/spike 010 = UV/OV spike	000
D1	Fault status	100 = Overload fault 101 = Discovery Fail 110 = Load disconnect 111 = Reserved for future	
D0	Fault status (LSB)		

## PORT CONTROL REGISTERS

The Port Control registers' (address 010) bit maps are shown in the following tables. These registers contain port specific control bits, accessible over the I<sup>2</sup>C bus, for setting the port powered and port LED modes. To conserve hardware resources, some common control functions have been assigned to available bit locations within these registers. To clarify usage, these common functions are identified as such in the table RANK column.

**Table 6. Port Control**  
**Write Register, Register Address = 010, Port Address = 000 (Port 1 Register)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Port fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	POR disable	Common	0 = Normal POR timing 1 = Force POR to a non-reset state	0
D5	Software RESET	Common	0 = Normal operation 1 = Reset all circuits and start a device POR timing cycle	0
D4	LED blink enable	Port	0 = LED is continuous 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to 0.00013 x TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V <sub>5</sub>	0
D1			00 = Port OFF or disable	
D0	Enable modes	Port	01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	0

**Table 7. Port Control**  
**Write Register, Register Address = 010, Port Address = 001 (Port 2 Register)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Overload fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	A/D advance	Common	0 = Normal mode 1 = Bypass offset correction ramp	0
D5	Class Limit 1	Common	Class Limit2, Class Limit1 0,0 = 160-mA classification current limit 0,1 = 80-mA classification current limit 1,0 = 40-mA classification current limit 1,1 = 20-mA classification current limit	0
D4	LED blink enable	Port	0 = LED is on continuous. 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to 0.00013 x TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V <sub>5</sub>	0
D1			00 = Port OFF or disable	
D0	Enable modes	Port	01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	0

**Table 8. Port Control**  
**Write Register, Register Address = 010, Port Address = 010 (Port 3 Register)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Overload fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	Discovery hold	Common	0 = Normal mode 1 = Hold A/D after detection	0
D5	Class Limit 2	Common	Class Limit2, Class Limit1 0,0 = 160-mA classification current limit 0,1 = 80-mA classification current limit 1,0 = 40-mA classification current limit 1,1 = 20-mA classification current limit	0
D4	LED blink enable	Port	0 = LED is on continuous. 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to $0.00013 \times$ TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V5	0
D1	Enable modes	Port	00 = Port OFF or disable	0
D0			01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	

**Table 9. Port Control**  
**Write Register, Register Address = 010, Port Address = 011 (Port 4 Register)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Overload fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	Overvoltage fault disable	Common	0 = Normal mode 1 = Disable all ports overvoltage timer	0
D5	A/D input select	Common	0 = Normal mode – select port currents 1 = Select port voltage	0
D4	LED blink enable	Port	0 = LED is on continuous. 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to $0.00013 \times$ TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V5	0
D1	Enable modes	Port	00 = Port OFF or disable	0
D0			01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	

**Table 10. Port Control**  
**Write Register, Register Address = 010, Port Address = 100 (Port 5 Register)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Overload fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	Undervoltage fault disable	Common	0 = Normal mode 1 = Disable all ports overvoltage timer	0
D5	Spare			0
D4	LED blink enable	Port	0 = LED is on continuous. 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to $0.00013 \times$ TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V5	0
D1				
D0	Enable modes	Port	00 = Port OFF or disable 01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	0

**Table 11. Port Control**  
**Write Register, Register Address = 010, Port Address = 101–111, (Port 6 through Port 8 Registers)**

BIT	FUNCTION	RANK	STATE	PRESET STATE
D7	Overload fault disable	Port	0 = Normal mode 1 = Disable the port overload timer	0
D6	Spare			0
D5	Spare			0
D4	LED blink enable	Port	0 = LED is on continuous. 1 = Blink the enabled LED at a fast-blink rate. Note fast-blink rate (in milliseconds) equivalent to $0.00013 \times$ TPS2383B clock (CLK). This could be as fast as 65 ms for a 500-kHz, TPS2383B clock.	0
D3	LED low-side enable	Port	1 = Enable the low-side FET and drive the LED pin low	0
D2	LED high-side enable	Port	1 = Enable the high-side FET and drive the LED pin to V5	0
D1				
D0	Enable modes	Port	00 = Port OFF or disable 01 = Discovery – classification – power on sequence 10 = Sample powered-mode current 11 = Power-down an active port	0

## RUN CURRENT/VOLTAGE

During power delivery, the average value of the port running current or voltage is available from the read register. The slope type converter used produces 12 bits of input offset corrected conversion with a typical integration or averaging period of approximately one line cycle (16 ms). The actual averaging period is set by the CLK frequency and is equivalent to 8192 periods of that frequency. The lower eight bits of this conversion are available at the port register 011. The remaining upper four bits and A/D status bits are available at register 100. The converter span is 4096 bits. The A/D conversion port displays the real time counter output and holds the final static value at the completion of conversion

**Table 12. Common Analog to Digital Conversion Port  
Read Register, Register Address = 011**

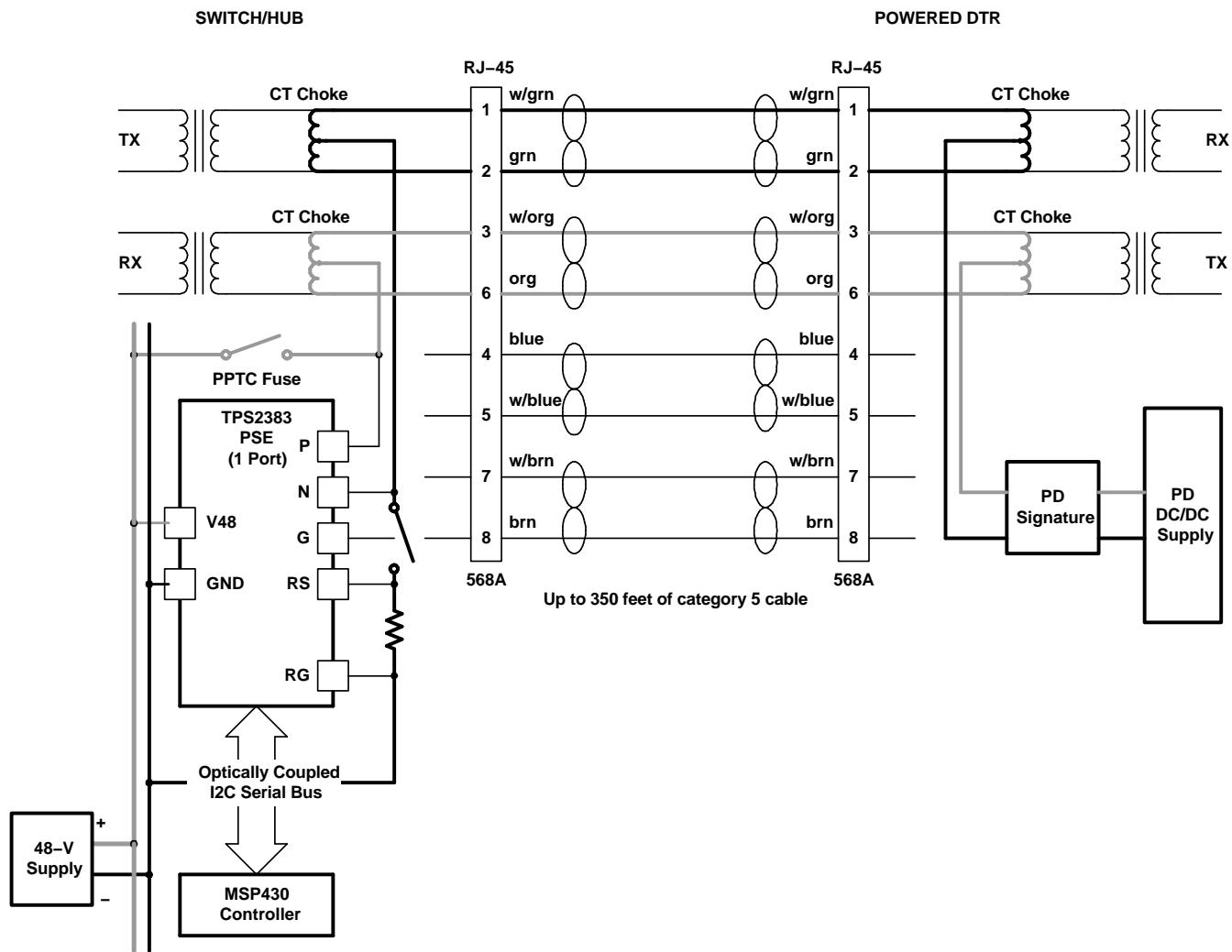
BIT	FUNCTION	STATE	PRESET STATE
D7	A2D bit 7	A/D lower bits	
D6	A2D bit 6		
D5	A2D bit 5		
D4	A2D bit 4		
D3	A2D bit 3		
D2	A2D bit 2		
D1	A2D bit 1		
D0	A2D bit 0		

**Table 13. Common Analog to Digital Conversion Port  
Read Register, Register Address = 100**

BIT	FUNCTION	STATE	PRESET STATE	
D7	A2D zero cross	0 = CINT is above zero threshold 1 = CINT is below zero threshold		
D6	A2D overflow	1 = A2D overflow detected		
D5	Reserved for test			
D4	Reserved for test			
D3	A2D bit 11	A/D upper bits		
D2	A2D bit 10			
D1	A2D bit 9			
D0	A2D bit 8			

**Table 14. Chip Identification/Revision  
Read Register, Register Address = 101**

BIT	FUNCTION	STATE	PRESET STATE
D7	Rev ID MSB	Internally hardwired (function of revision)	0
D6	Rev ID		
D5	Rev ID LSB		
D4	Device ID MSB		
D3	Device ID		
D2	Device ID		
D1	Device ID		
D0	Device ID LSB		



**Figure 2. System Block Diagram**

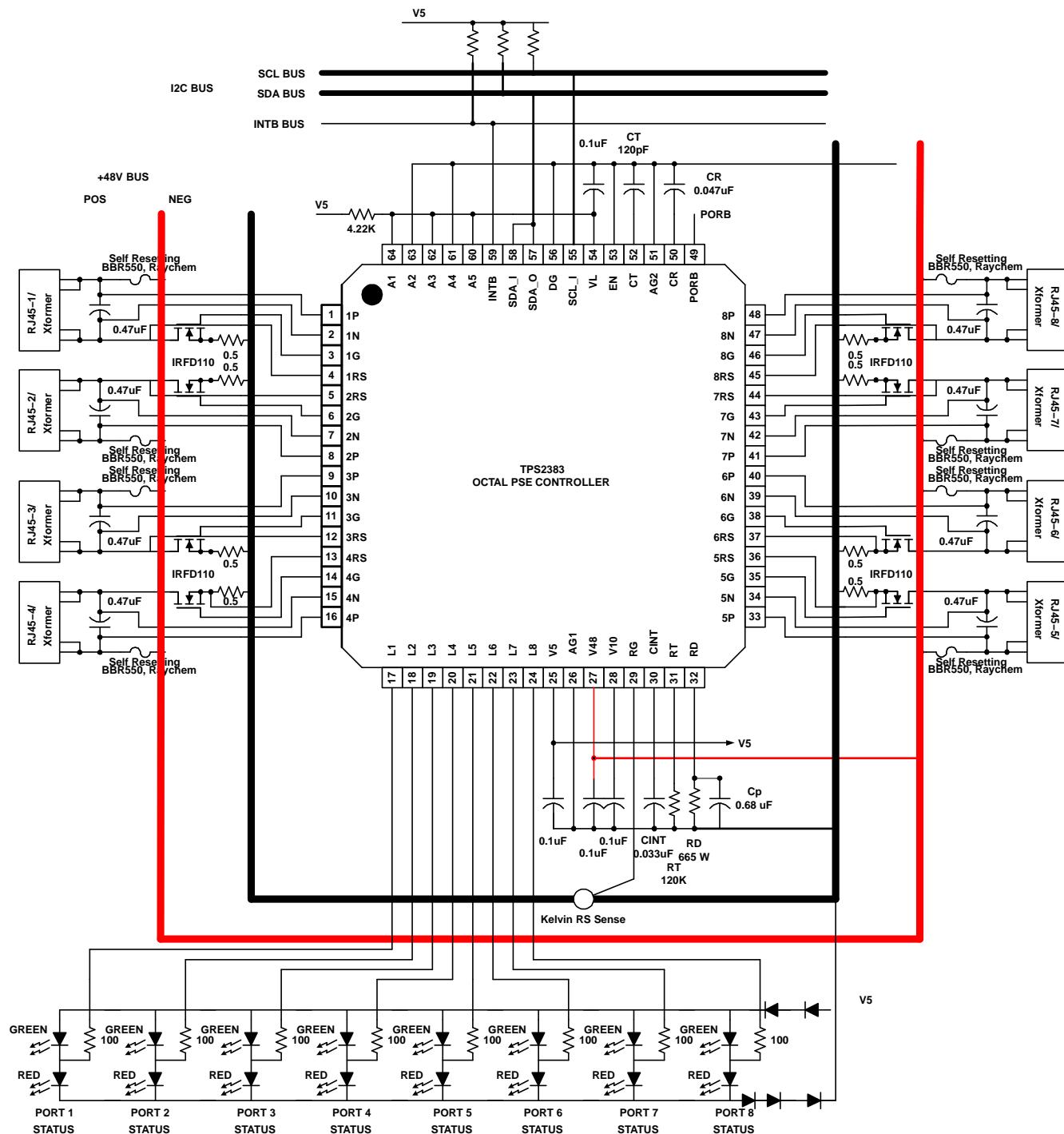
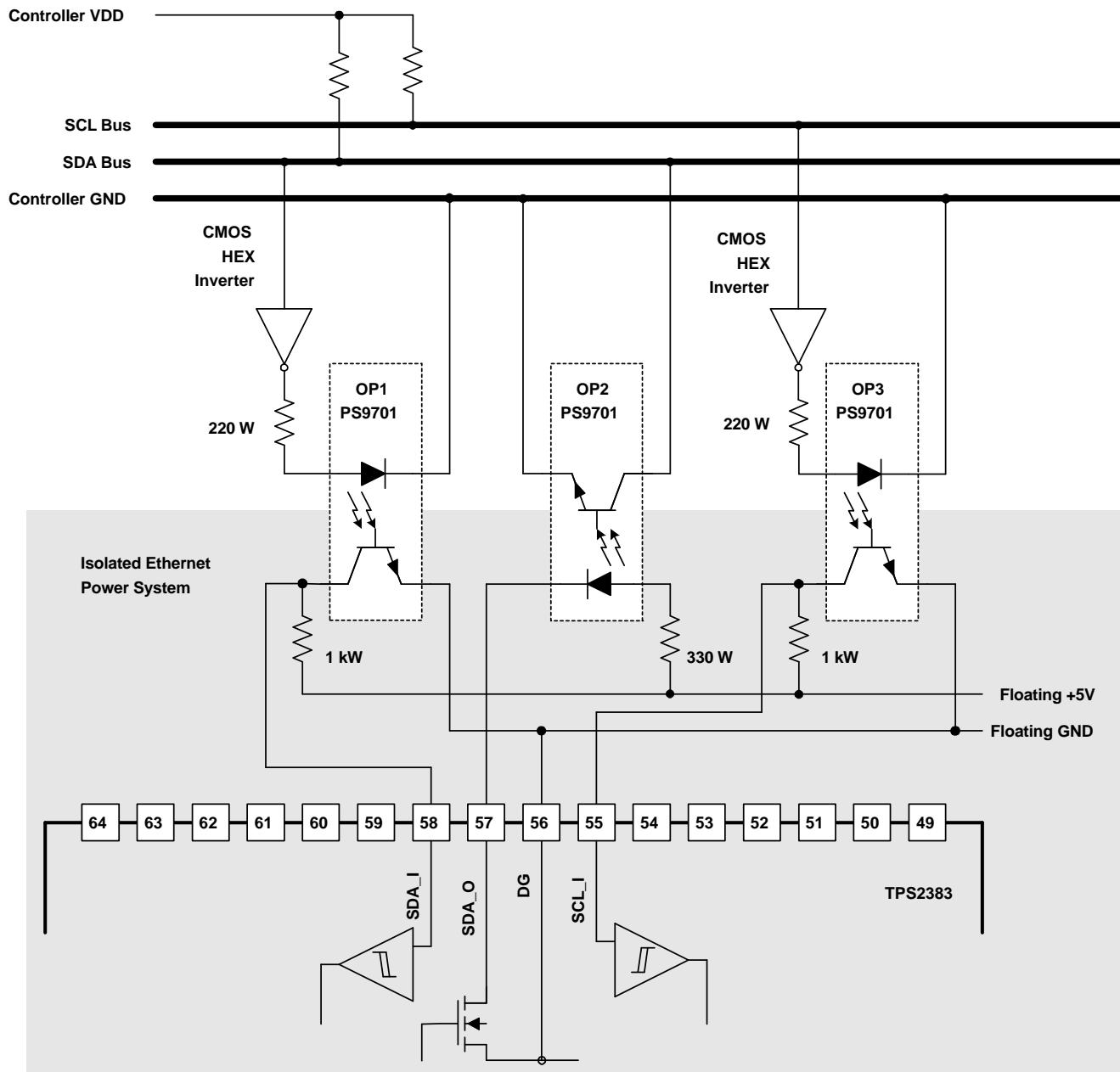


Figure 3. Typical Eight-Port Application



**Figure 4. Using Optoisolators for I<sup>2</sup>C Bus/System Ground Isolation**

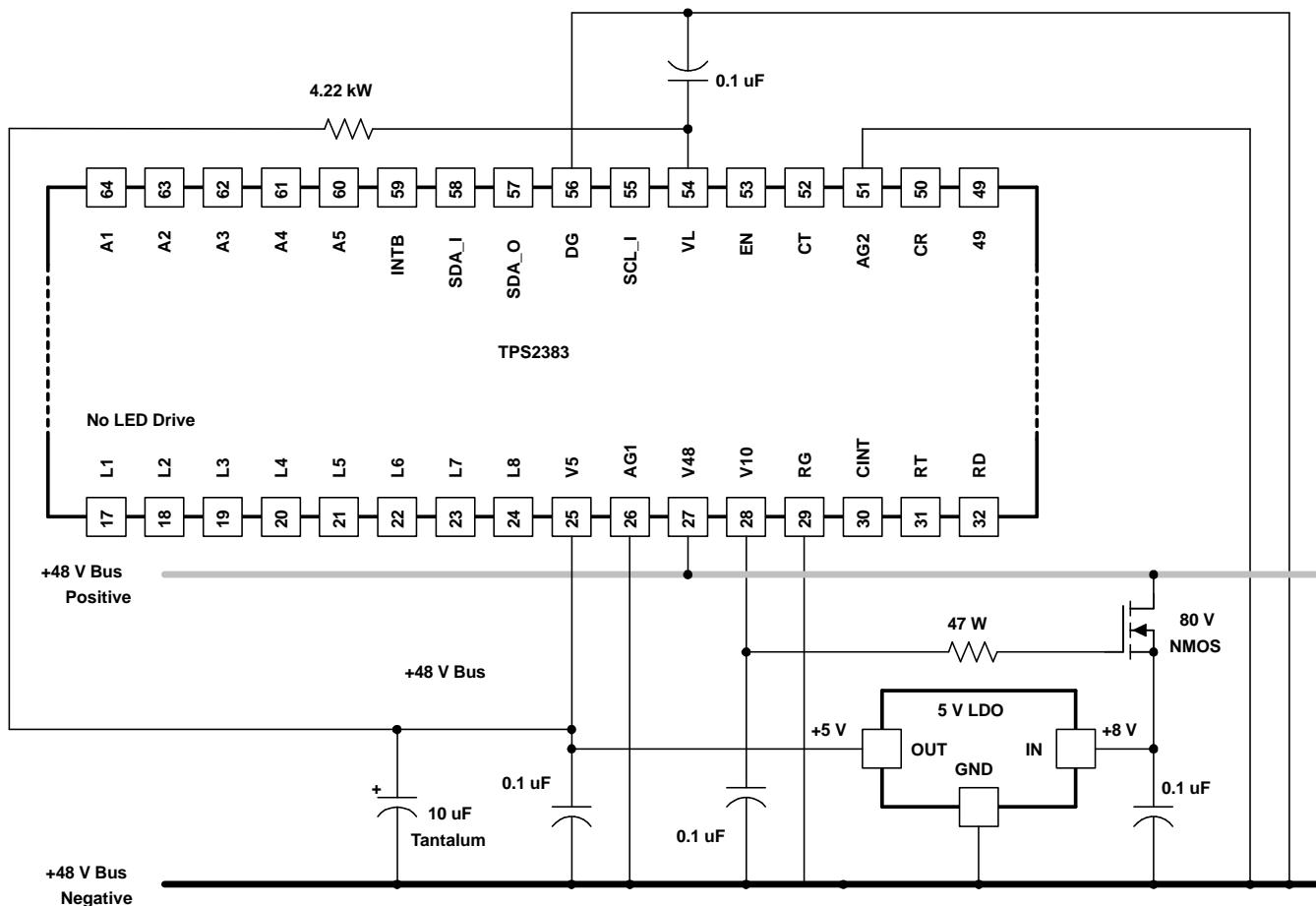


Figure 5.  $V_5$  and  $V_L$  Generation from Single  $+48\text{-V}$  Supply

**PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TPS2383APM	NRND	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383APMG4	NRND	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383APMR	NRND	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383APMRG4	NRND	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383BPM	ACTIVE	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383BPMG4	ACTIVE	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383BPMR	ACTIVE	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TPS2383BPMRG4	ACTIVE	LQFP	PM	64		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

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**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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Interface	interface.ti.com	Digital Control	<a href="http://www.ti.com/digitalcontrol">www.ti.com/digitalcontrol</a>
Logic	logic.ti.com	Military	<a href="http://www.ti.com/military">www.ti.com/military</a>
Power Mgmt	power.ti.com	Optical Networking	<a href="http://www.ti.com/opticalnetwork">www.ti.com/opticalnetwork</a>
Microcontrollers	microcontroller.ti.com	Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
		Telephony	<a href="http://www.ti.com/telephony">www.ti.com/telephony</a>
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